

<b>Notice of References Cited</b>	Application/Control No. 10/006,962	Applicant(s)/Patent Under Reexamination SCHAFFER ET AL.	
	Examiner Rip A. Lee	Art Unit 1713	Page 1 of 1

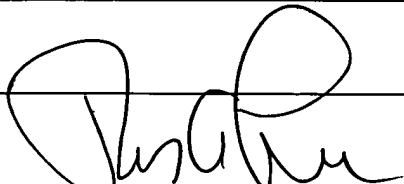
#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,554,217 A	09-1996	Babler	106/494
	B	US-5,880,193 A	03-1999	Berke et al.	524/385
	C	US-2002/0161083 A1	10-2002	Schafer et al.	524/265
	D	US-2002/0098435 A1	07-2002	Rohr et al.	430/108.22
	E	US-6,365,648 B1	04-2002	Couperus et al.	523/340
	F	US-6,239,201 B1	05-2001	Edelmann et al.	524/148
	G	US-5,667,580 A	09-1997	Babler	106/499
	H	US-5,455,288 A	10-1995	Needham	523/205
	I	US-5,439,968 A	08-1995	Hyche	524/504
	J	US-4,244,863	01-1981	Hemmerich et al.	260/42.55
	K	US-4,168,180	09-1979	Peabody	106/308 M
	L	US-4,127,422	11-1978	Guzi et al.	106/308 Q
	M	US-3,755,244	08-1973	Hart	260/41 R

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 95/31507 A1	11-1995	International	Wolbrink et al.	C09B 67/20
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	 <span style="float: right;">October 08, 2003</span>

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.